

AMENDMENTS TO THE CLAIMS

This listing of the claims replaces all prior versions, and listings of the claims in the application:

1. (Currently Amended) A system adapted to analyze a concentration of a selected gas in a gas sample, the system comprising:
 - a source adapted to emit radiation of a specified intensity and wavelength along an optical path such that the radiation is absorbed by the selected gas in the gas sample being analyzed;
 - an infrared radiation detector disposed along the optical path in optical communication with the source and adapted to detect an intensity of the emitted radiation by the source after the radiation has passed through the gas sample; and
 - a sample cell adapted to be disposed between the source and infrared radiation detector, wherein the sample cell includes a gas inlet disposed at a first end portion of the sample cell, a gas outlet disposed at a second end portion of the sample cell, and a gas flow passage defined in the sample cell between the gas inlet and the gas outlet, wherein the gas flow passage is generally parallel to that intersects the optical path between the source and the detector such that the gas flow passage defines a sample chamber, wherein a length of the gas flow passage defining the sample chamber is greater than a width of the gas flow passage, and wherein at least a portion of a wall defining the optical pathgas flow passage includes an infrared reflective surface so as to direct rays of radiation from the source to the infrared radiation detector generally along the optical path; and
 - ~~a half-ball lens or a ball lens disposed so as to receive the radiation from the source and direct rays of the radiation in a manner so as to be substantially parallel to each other.~~
2. (Currently Amended) The system of claim 1, wherein the interior infrared reflective surface is selected from group consisting of aluminum and gold.

3. (Currently Amended) The system of claim 1, wherein the ~~interior~~-infrared reflective surface comprises a high index material.

Claims 4 and 5. (Cancelled).

6. (Currently Amended) A system for analyzing the concentration of a selected gas in a gas sample, comprising:

a source adapted to emit radiation of a specified intensity and wavelength such that the radiation is absorbed by the selected gas in the gas sample being analyzed;

a ~~high numerical aperture half ball lens or a ball lens disposed so as to receive~~ radiation from the source and direct the emitted rays in a manner to be substantially parallel to each other; and

an infrared radiation detector in optical communication with the emitter and adapted to detect an intensity of the emitted radiation by the source after the radiation has passed through the gas sample; and

~~a sample cell disposed between the source and the infrared radiation detector, wherein the sample cell includes a gas inlet disposed at a first end portion of the sample cell, a gas outlet disposed at a second end portion of the sample cell, wherein a gas flow passage is defined in the sample cell between the gas inlet and the gas outlet, wherein the gas flow passage is generally parallel to an optical path between the source and the detector such that the gas flow passage defines a sample chamber, and wherein a length of the gas flow passage defining the sample chamber is greater than a width of the gas flow passage.~~

Claim 7-9. (Cancelled).

10. (Currently Amended) A method of analyzing a concentration of a selected gas in a gas sample comprising:

providing a sample cell adapted to be disposed between the source and infrared radiation detector, wherein the sample cell includes a gas inlet disposed at a first end portion of the sample cell, a gas outlet disposed at a second end portion of the sample cell, and a gas flow passage defined in the sample cell between the gas inlet and the gas outlet, wherein the gas flow passage is generally parallel to the optical path between the source and the detector such that the gas flow passage defines a sample chamber, wherein a length of the gas flow passage defining the sample chamber is greater than a width of the gas flow passage, and wherein at least a portion of a wall defining the gas flow passage includes an infrared reflective surface so as to direct rays of radiation from the source to the infrared radiation detector generally along the optical path; sample cell comprising a sample cell body having a gas flow passage defined therethrough, a sample cell chamber defined in the sample cell body such that the sample cell chamber defines a portion of the gas flow passage and at least a portion of an optical path, wherein at least a portion of a wall of the sample cell chamber defining the optical path includes an infrared reflective material, and wherein the sample cell includes an optical aperture defined in a portion of the sample cell;

providing a half ball lens or a ball lens disposed so as to receive radiation from a source;

emitting infrared radiation of a specified intensity and wavelength from the source through the half ball lens or ball lens and through the aperture along the optical path through the sample chamber;

absorbing a portion of the radiation by the selected gas in the sample cell chamber; and

detecting an intensity of the radiation by an infrared radiation detector disposed along the optical path in optical communication with the source after the radiation has passed through the gas sample in the sample chamber.

Claim 11. (Cancelled).

12. (Currently Amended) A method of analyzing a concentration of a selected gas in a gas sample comprising:

providing a sample cell adapted to be disposed between the source and infrared radiation detector, wherein the sample cell includes a gas inlet disposed at a first end portion of the sample cell, a gas outlet disposed at a second end portion of the sample cell, and a gas flow passage defined in the sample cell between the gas inlet and the gas outlet, wherein the gas flow passage is generally parallel to the optical path between the source and the detector such that the gas flow passage defines a sample chamber, wherein a length of the gas flow passage defining the sample chamber is greater than a width of the gas flow passage, and wherein at least a portion of a wall defining the gas flow passage includes an infrared reflective surface so as to direct rays of radiation from the source to the infrared radiation detector generally along the optical;

emitting infrared radiation of a specified intensity and wavelength from a source through the aperture along an optical path through the sample chamber;

providing a high numerical aperture half-ball lens or a ball-lens disposed along the optical path so as to receive radiation from the source;

passing the radiation through the high numerical aperture half-ball lens or a ball-lens;

passing the radiation through a gas sample in the sample chamber after having passed through the high numerical aperture half-ball lens or a ball-lens;

absorbing a portion of the radiation by the selected gas such a gas sample; and detecting an intensity of the radiation by an infrared radiation detector disposed along the optical path in optical communication with the source after the radiation has passed through the gas sample in the sample chamber.

13. (New) The system of claim 1, further comprising a high numerical aperture lens disposed so as to receive radiation from the emitter and direct the emitted rays in a manner to be substantially parallel to each other.

14. (New) The system of claim 13, wherein the high numerical aperture lens is a half-ball lens or a ball lens.

15. (New) The system of claim 6, wherein the high numerical aperture lens is a half-ball lens or a ball lens.

16. (New) The method of claim 10, further comprising providing a high numerical aperture lens disposed so as to receive radiation from the emitter, and wherein emitting infrared radiation along the optical path includes passing the emitted rays through the high numerical aperture lens.